



SLP80N07T 68V N -Channel MOSFET

General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.

This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

Application

☑PWM Application☑Load Switch☑Power Management

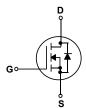
Features

- N-Channel:68V 80A

 $R_{DS(on)Typ}$ = 6.5m Ω @VGS = 10 V

- Very Low On-resistance R_{DS(ON)}
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability





Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter	SLP80N07T	Units	
V_{DSS}	Drain-Source Voltage	68	V	
Ι _D	Drain Current - Continuous (T _C = 25°C	:)	80	Α
טו	- Continuous (T _C = 100°C)		52	Α
I _{DM}	Drain Current - Pulsed	320	Α	
V_{GSS}	Gate-Source Voltage		±25	V
E _{AS}	Single Pulsed Avalanche Energy	260	mJ	
P _D	Power Dissipation (T _C = 25°C)		156	W
R ₀ JC	Thermal Resistance, Junction to Case		0.8	°C/W
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150	ဇ	
TL	Maximum lead temperature for soldering p 1/8" from case for 5 seconds	300	ဇ	

^{*} Drain current limited by maximum junction temperature.

Max Units

Package Marking

Symbol

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLP80N07T	SLP80N07T	TO-220C	Tube	1000	5000

Electrical Characteristics

Parameter

T_C = 25°C unless otherwise noted

Test Conditions

Off Ch	Off Characteristics									
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 uA	68			V				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =68 V, V _{GS} = 0 V			1	uA				
Igssf	Gate-Body Leakage Current, Forward	V _{GS} = 25V, V _{DS} = 0 V			100	nA				
IGSSR	Gate-Body Leakage Current, Reverse	$V_{GS} = -25 \text{ V}. V_{DS} = 0 \text{ V}$			-100	nA				

On Characteristics

	$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \text{ uA}$	2.0	3.0	4.0	V
I	R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} =10 V, I _D = 20A		6.5	8.5	mΩ

Dynamic Characteristics

C _{iss}	Input Capacitance		-	5840	-	pF
Coss	Output Capacitance	$V_{DS} = 35 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz	1	223	-	pF
Crss	Reverse Transfer Capacitance			208	-	рF

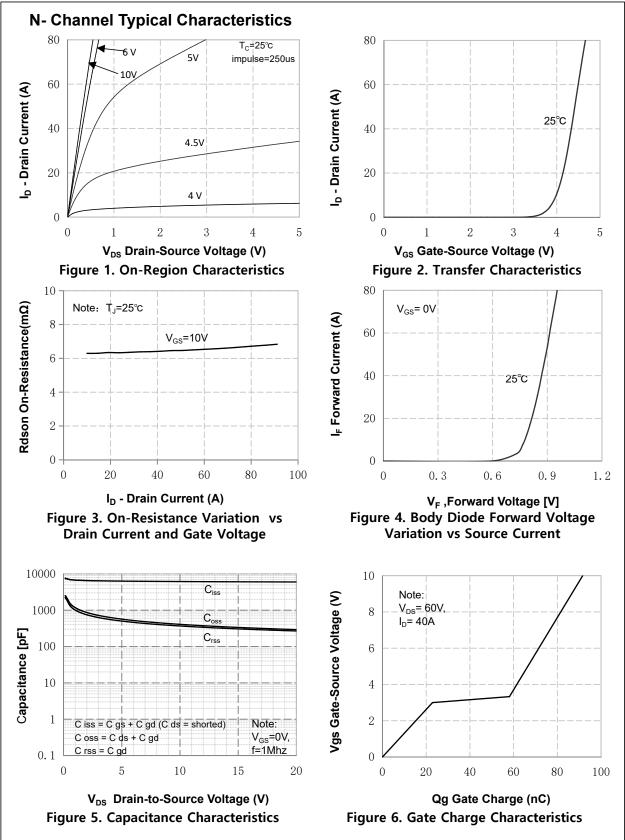
Switching Characteristics

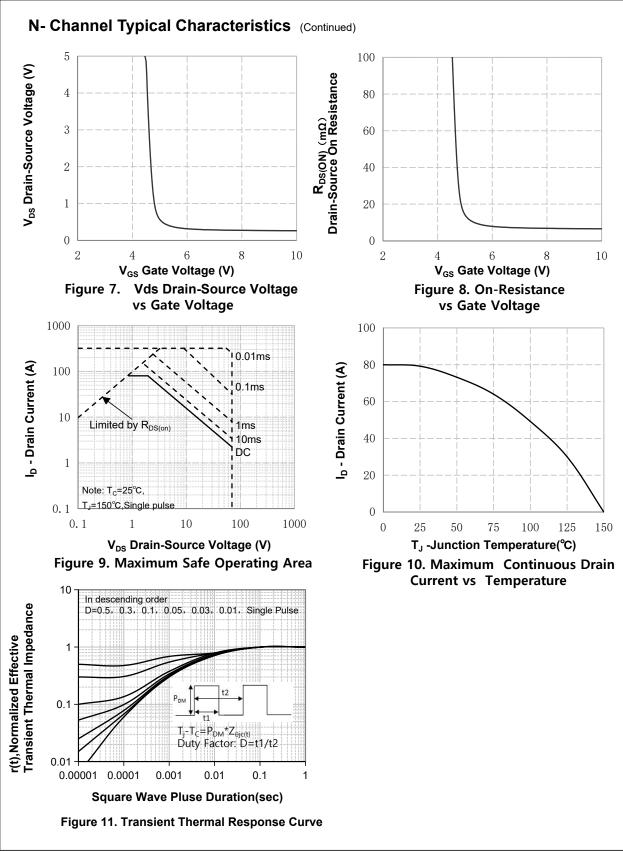
$t_{d(on)}$	Turn-On Delay Time		-	23		ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DS} = 35V,$	-	22		ns
$t_{d(off)}$	Turn-Off Delay Time	$R_L = 3\Omega$, $I_D = 40A$ $Tj = 25$ °C (Note 3)	ı	46	1	ns
t _f	Turn-Off Fall Time		ı	9	-	ns
Q_g	Total Gate Charge	$V_{DS} = 60V, I_{D} = 40A,$	I	91.6	ŀ	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 10V$ (Note 3)	ı	22.8	-	nC
Q_gd	Gate-Drain Charge		-	35		nC
R_G	Gate Resistance	f = 1MHz	1	3.3	1	Ω

Drain-Source Diode Characteristics and Maximum Ratings

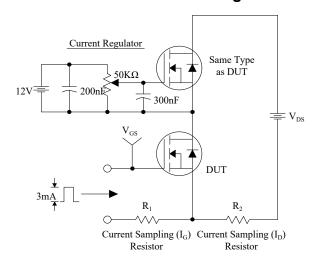
	Is	Maximum Continuous Drain-Source Diode Forward Current	-	 80	Α
	I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		 320	Α
,	V_{SD}	Drain to Source Diode Forward Voltage, V _{GS} = 0V, I _{SD} = 20A, T _J = 25°C		 1.2	V

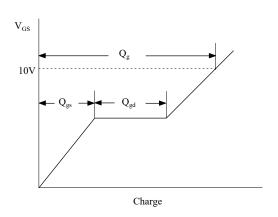
- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- 2. EAS condition: T $_{\rm J}$ =25°C, V $_{\rm DD}$ =50V, V $_{\rm G}$ =10V,L=0.5mH. 3. Pulse Test: Pulse Width≤300 μ s, Duty Cycle≤0.5%



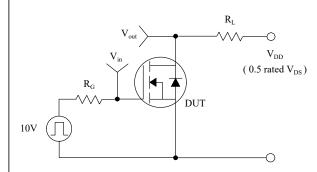


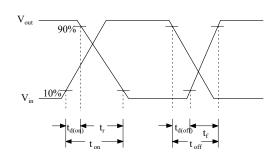
Gate Charge Test Circuit & Waveform



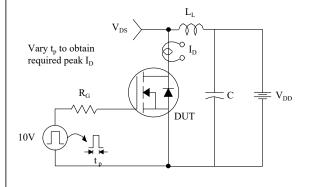


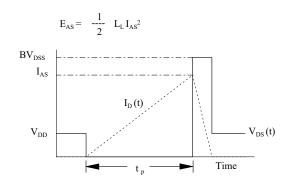
Resistive Switching Test Circuit & Waveforms



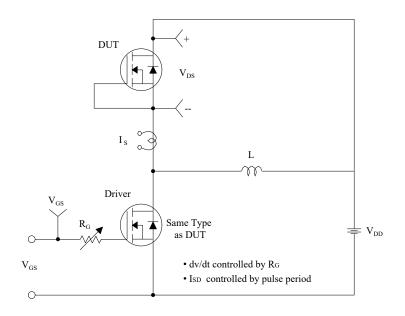


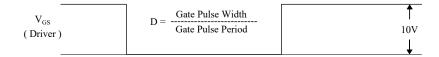
Unclamped Inductive Switching Test Circuit & Waveforms

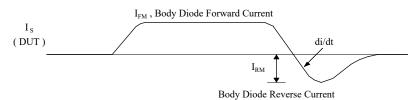


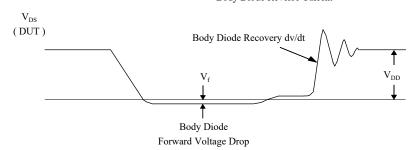


Peak Diode Recovery dv/dt Test Circuit & Waveforms

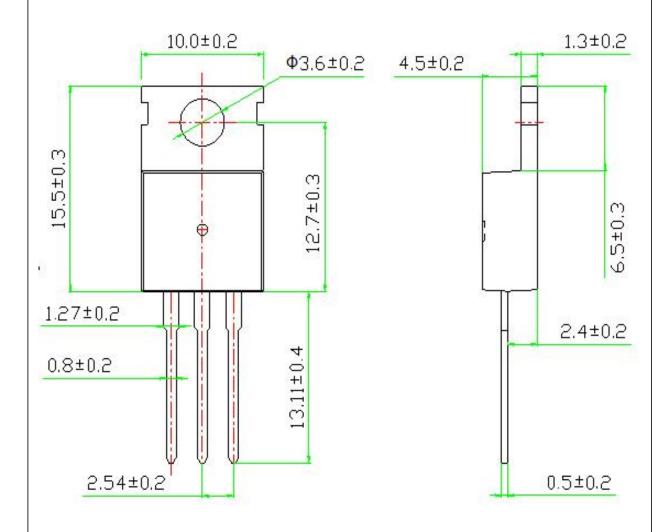








TO-220C OUTLINE



NAME	TO-220C OUTLINE	UNIT	mm	DESIGNED	Shawn Chen	THIRD ANGLE SYSTEM
DWGNO		PAGE	1 OF 1	CHECKED		∌]
VERSION	Ver1.0	ISSUE DATE		APPROVED		

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